

Notice of References Cited			Application/Control No. 10/535,233	Applicant(s)/Patent Under Reexamination OTA ET AL.	
			Examiner David Buttner	Art Unit 1712	Page 1 of 1

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*	B	US-5,284,918	02-1994	Huynh-Tran et al.	525/124
*	C	US-4,722,969	02-1988	Huynh-Tran et al.	525/123
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	M	US-			

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	U	Encyclopedia of Polymer Science and Engineering Vol 1; page 234; 1985.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.